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INFO	DMATIO	N DIS	CLOSURE	Application Number	10/749552	
_				Filing Date	January 2, 2004	
31A)	STATEMENT BY APPLICANT			First Named Inventor	Kazuo NISHI et al.	
	(use as many sh	ieeus as nec	essary)	Group Art Unit	2915	
				Examiner Name	Warren	
Sheet	1	of	1	Attorney Docket Number	0756-7243	

				U.S. PATENT DOCUMEN	rs	
	Cite No.	U.S. Patens Document		Name of Patentee or Applicant of Cited	Date of Publication of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ³ (if known)	Document	MM-DD-YYYY	
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Examiner Signature	Matthew E. Wane	Date Considered	5/31/05	

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Substitute for form 1449A/PTO	Co	mplete if Known
INFORMATION DISCLOSURE	Application Number	10/749,552
STATES ENT BY APPLICANT	Filing Date	January 2, 2004
STATEMENT BY APPLICANT	First Named Inventor	Kazuo NISHI et al.
(us a many sheets as necessary)	Group Art Unit	2815
20 7004 55	Examiner Name	Worker
Wheet 1 5 of 1	Attorney Docket Number	0756-7243

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Examiner Cite Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the Initials No. item (book, magazine, journal, serial, symposium, catalog, etc.)., date, page(s), volume-issue number(s), publisher, city and/or country where published.							T ²
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Signature	7.00	Considered

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PTO/SB/08A (08-00)
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INEO	DMATION)ISC	OSIDE	Application Number	10/749,552	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Filing Date	January 2, 2004	
51A				First Named Inventor	Kazuo NISHI et al.	
(use as many sheets as necessary)			אראב)	Group Art Unit	2815	
				Examiner Name	M. Warren	
Sheet	1	of	1	Attorney Docket Number	0756-7243	

			U.S. PATENT DOCUMEN	TS	
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		Number Kind Code ² (If known)	Document	MM-DO-3111	
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		Office	Number ⁴	Kind Code ³ (If known)	Applicant of Cited Document	MM-DD-YYYY	Figures Appear	7*
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